

**Notice of References Cited**Application/Control No.  
09/904,348Applicant(s)/Patent Under  
Reexamination  
TOOMEY, PATRICKExaminer  
Douglas N WashburnArt Unit  
2863

Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4128011	12-1978	Savage	73/579
	B	US-5095465 /	03-1992	Stokoe II	367/14
	C	US-5520052 /	05-1996	Pechersky	73/579
	D	US-5679899 /	10-1997	Webster et al.	73/656
	E	US-5798981 /	08-1998	Littlejohn et al.	367/13
	F	US-6186004 B1 /	02-2001	Kaduchak et al.	73/596
	G	US-6324912 B1 /	12-2001	Wooh	73/629
	H	US-6246355 B1 /	06-2001	Miceli et al.	342/22
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wooh, Shi-Chang; "Flaw Detection System Using Acoustic Doppler Effect"; US Patent Application Publication; US2001/0015104 A1; Aug 2001
	V	Wooh, Shi-Chang; "Flaw Detection System Using Acoustic Doppler Effect"; US Patent Application Publication; US2001/0020390 A1; Sep 2001
	W	Wooh, Shi-Chang; "Flaw Detection System Using Acoustic Doppler Effect"; US Patent Application Publication; US2001/0045130 A1; Nov 2001
	X	Lewis, H; Rogoyski, A; "Method Of Investigating Vibrations And An Apparatus Therefor"; US Patent Application Publication; US2002/0024331 A1; Feb 2002

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**Application/Control No.  
09/904,348Applicant(s)/Patent Under  
Reexamination  
TOOMEY, PATRICKExaminer  
Douglas N WashburnArt Unit  
2863

Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Polytec Product Catalog; Issue VIB-9607-E-15T; July 1996; pp 1-15 ✓
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.